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Jochumsen et al.

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(54) **RACK FOR SUPPORTING A MULTI-POINT ELECTRICAL PROBE HOLDER**

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(**) Term: **14 Years**

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(52) **U.S. Cl.**
USPC **D10/80**; D10/103

(58) **Field of Classification Search**
CPC G01R 1/06783; G01R 27/08; G01R 27/14; G01R 27/0408; G01R 27/0483; G01R 27/0404; G01R 31/2648; G01R 31/2891; G01R 31/2867
USPC D8/354; D10/80, 94, 103; D13/173; D14/217; 324/72.5, 149, 545, 324/713-719, 754.03, 754.04, 754.5, 324/754.11, 754.09, 754.2, 755.01, 755.07, 324/756.01, 756.02, 757.01, 73.1

See application file for complete search history.

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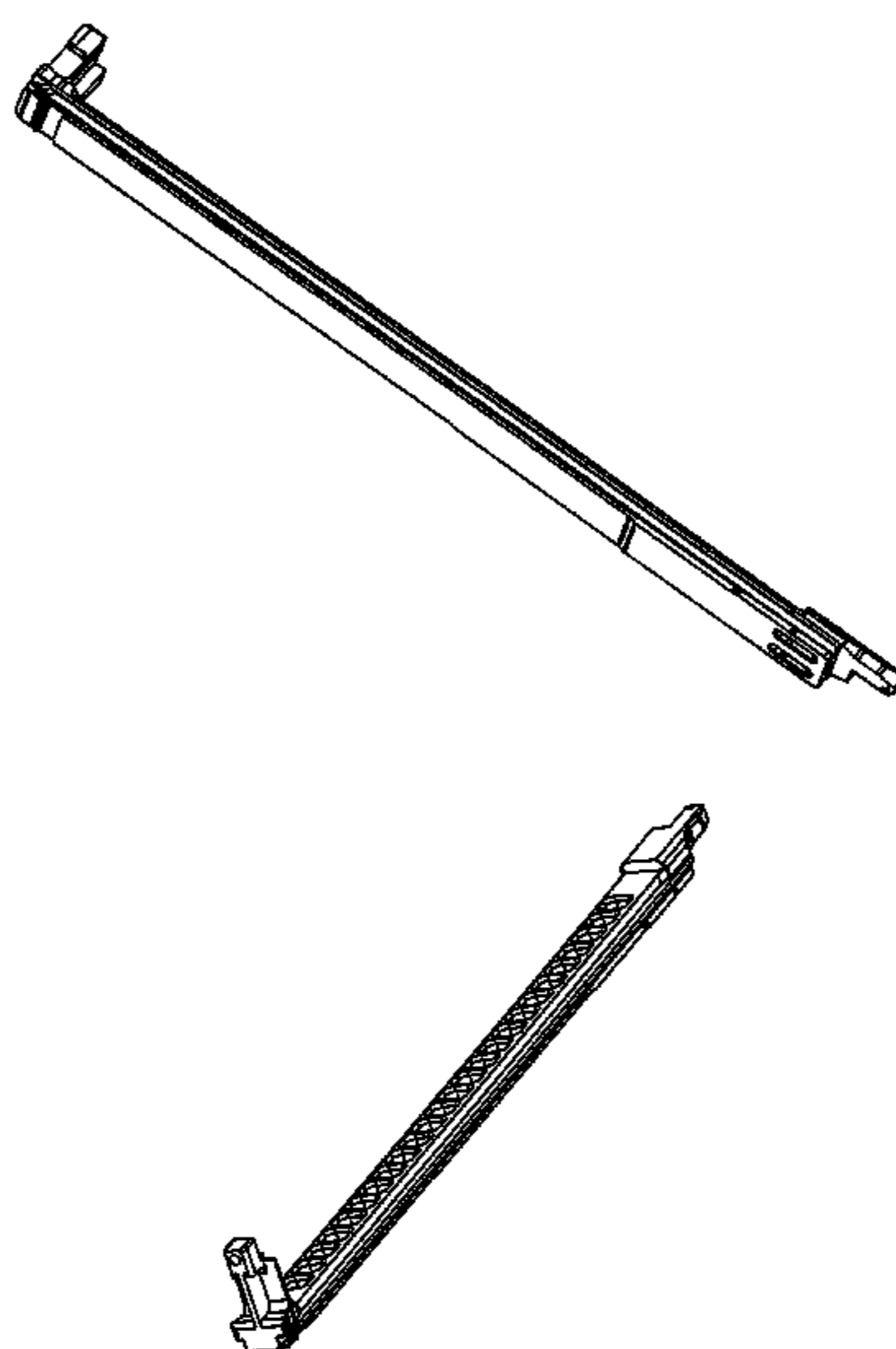
(57) **CLAIM**

The ornamental design for a rack for supporting a multi-point electrical probe holder, as shown.

DESCRIPTION

FIG. 1 is a perspective view, taken from the bottom, rear, and left side, of a rack for supporting a multi-point electrical probe holder, in accordance with our new design; FIG. 2 is a perspective view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1, taken from the top, front, and left side; FIG. 3 is a bottom plan view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1; FIG. 4 is a right side elevation view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1; FIG. 5 is a left side elevation view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1; FIG. 6 is a top plan view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1; FIG. 7 is a rear elevation view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1; and, FIG. 8 is a front elevation view of the rack for supporting a multi-point electrical probe holder shown in FIG. 1.

1 Claim, 8 Drawing Sheets



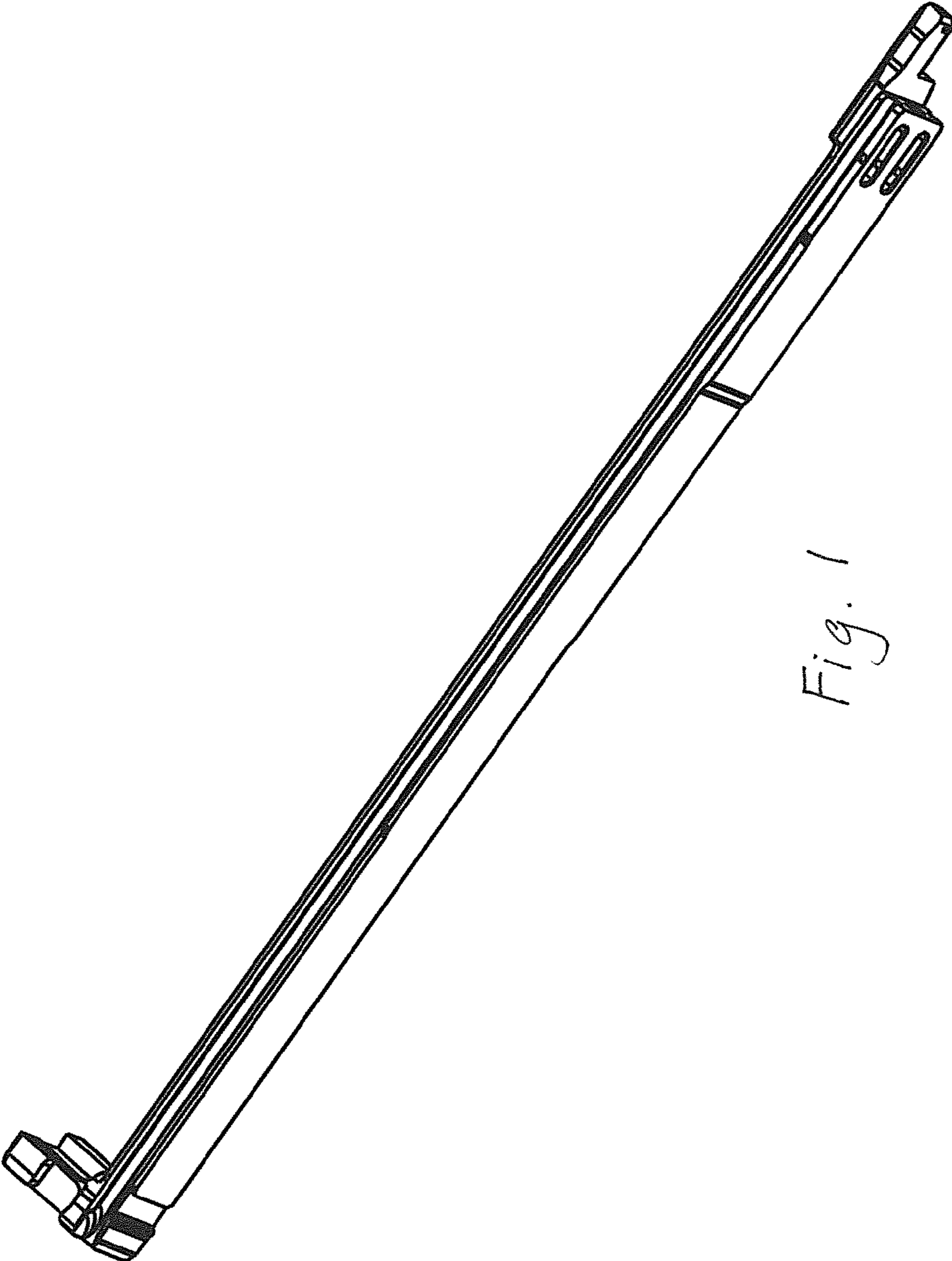


Fig. 1

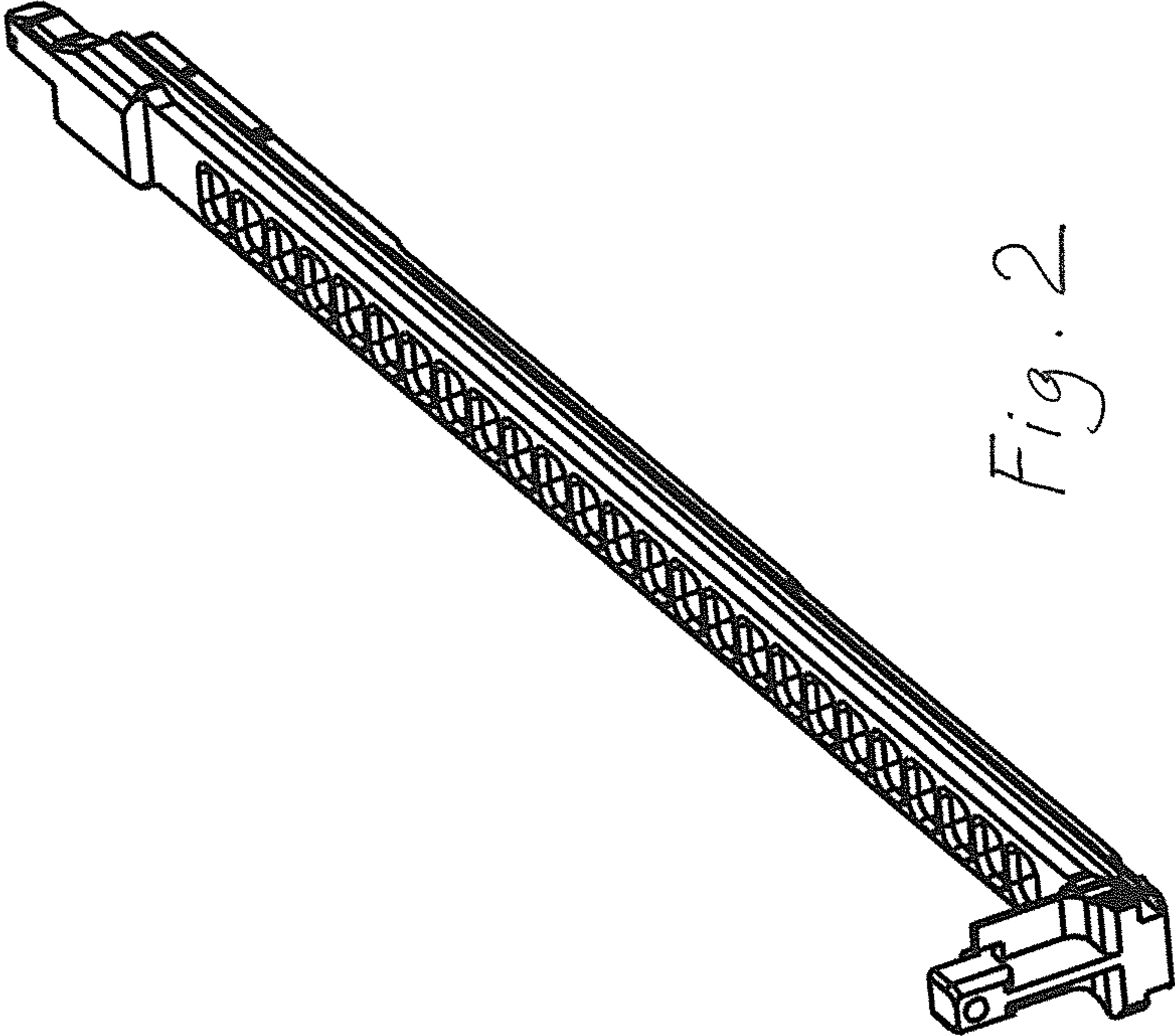


Fig. 2



Fig. 3

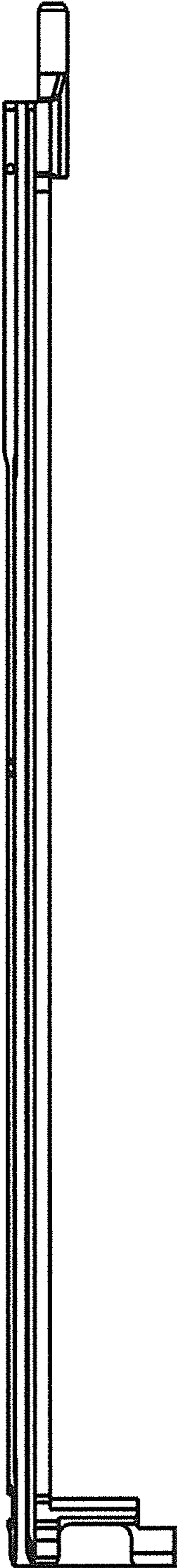


Fig. 4

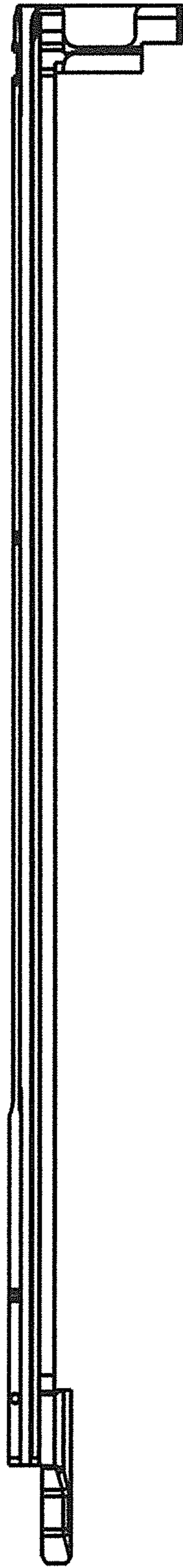


Fig. 5



Fig. 6

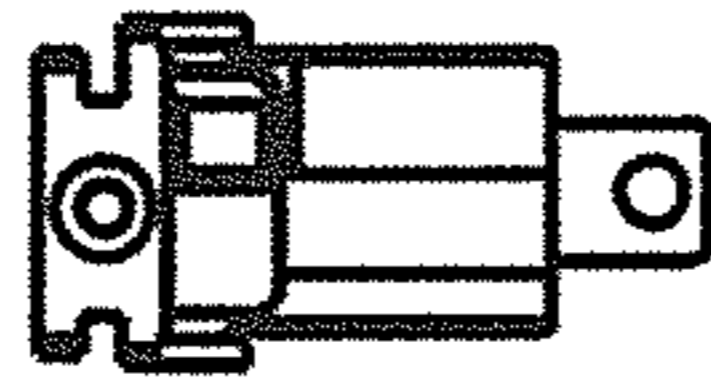


Fig. 7

Fig. 8

